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STMicroelectronics STW52NK25Z

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STW52NK25Z

N-CHANNEL 250V - 0.033Ω - 52A TO-247 Zener-Protected SuperMESH™ MOSFET

Table 1: General Features

TYPE	V _{DSS}	R _{DS(on)}	I _D	Pw
STW52NK25Z	250 V	$< 0.045~\Omega$	52 A	300 W

- TYPICAL $R_{DS}(on) = 0.033 \Omega$
- EXTREMELY HIGH dv/dt CAPABILITY
- 100% AVALANCHE TESTED
- GATE CHARGE MINIMIZED
- VERY LOW INTRINSIC CAPACITANCES
- VERY GOOD MANUFACTURING REPEATIBILITY

DESCRIPTION

The SuperMESH™ series is obtained through an extreme optimization of ST's well established strip-based PowerMESH™ layout. In addition to pushing on-resistance significantly down, special care is taken to ensure a very good dv/dt capability for the most demanding applications. Such series complements ST full range of high voltage MOS-FETs including revolutionary MDmesh™ products.

APPLICATIONS

- HIGH CURRENT, HIGH SPEED SWITCHING DC CHOPPERs
- IDEAL FOR OFF-LINE POWER SUPPLIES, ADAPTORS AND PFC

Figure 1: Package

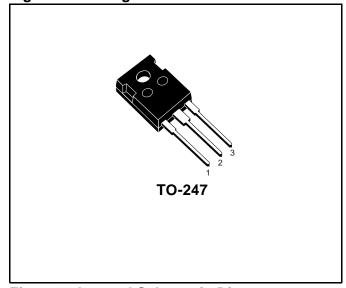


Figure 2: Internal Schematic Diagram

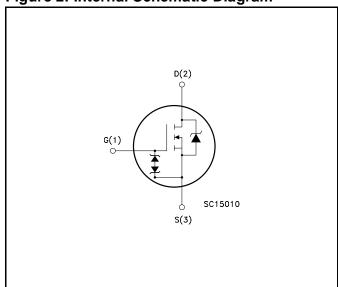


Table 2: Order Codes

SALES TYPE	MARKING	PACKAGE	PACKAGING
STW52NK25Z	W52NK25Z	TO-247	TUBE



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Table 3: Absolute Maximum ratings

Symbol	Parameter	Value	Unit
V _{DS}	Drain-source Voltage (V _{GS} = 0)	250	V
V_{DGR}	Drain-gate Voltage (R_{GS} = 20 kΩ)	250	V
V_{GS}	Gate- source Voltage	± 30	V
I _D	Drain Current (continuous) at T _C = 25°C	52	А
I _D Drain Current (continuous) at T _C = 100°C		32.76	А
I _{DM} (●)	Drain Current (pulsed)	208	А
Ртот	Total Dissipation at T _C = 25°C	300	W
	Derating Factor	2.38	W/°C
V _{ESD(G-S)} Gate source ESD(HBM-C=100pF, R=1.5KΩ)		6000	V
dv/dt (1) Peak Diode Recovery voltage slope		4.5	V/ns
T _j Operating Junction Temperature Storage Temperature		-55 to 150	°C

^(•) Pulse width limited by safe operating area

Table 4: Thermal Data

Rthj-case	Thermal Resistance Junction-case Max	0.42	°C/W
Rthj-amb	Thermal Resistance Junction-ambient Max	30	°C/W
T _I	Maximum Lead Temperature For Soldering Purpose	300	

Table 5: Avalanche Characteristics

Symbol	Parameter	Max Value	Unit
I _{AR}	Avalanche Current, Repetitive or Not-Repetitive (pulse width limited by T _j max)	52	Α
E _{AS}	Single Pulse Avalanche Energy (starting $T_j = 25$ °C, $I_D = I_{AR}$, $V_{DD} = 50$ V)	500	mJ

Table 6: GATE-SOURCE ZENER DIODE

Symbol	Parameter	Test Conditions	Min.	Тур.	Max.	Unit
BV _{GSO}	Gate-Source Breakdown Voltage	Igs=± 1mA (Open Drain)	30			V

PROTECTION FEATURES OF GATE-TO-SOURCE ZENER DIODES

The built-in back-to-back Zener diodes have specifically been designed to enhance not only the device's ESD capability, but also to make them safely absorb possible voltage transients that may occasionally be applied from gate to source. In this respect the Zener voltage is appropriate to achieve an efficient and cost-effective intervention to protect the device's integrity. These integrated Zener diodes thus avoid the usage of external components.

⁽¹⁾ $I_{SD} \le 52A$, $di/dt \le 200A/\mu s$, $V_{DD} \le V_{(BR)DSS}$, $T_i \le T_{JMAX}$.



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ELECTRICAL CHARACTERISTICS (T_{CASE} =25°C UNLESS OTHERWISE SPECIFIED)

Table 7: On/Off

Symbol	Parameter	Min.	Тур.	Max.	Unit	
V _{(BR)DSS}	Drain-source Breakdown Voltage	$I_D = 1 \text{ mA}, V_{GS} = 0$	250			V
I _{DSS}	Zero Gate Voltage Drain Current (V _{GS} = 0)	V _{DS} = Max Rating V _{DS} = Max Rating, T _C = 125 °C			1 50	μA μA
I _{GSS}	Gate-body Leakage Current (V _{DS} = 0)	V _{GS} = ± 20V			±10	μΑ
V _{GS(th)}	Gate Threshold Voltage	$V_{DS} = V_{GS}, I_{D} = 150 \mu A$	3	3.75	4.5	V
R _{DS(on)}	Static Drain-source On Resistance	V _{GS} = 10V, I _D = 26 A		0.033	0.045	Ω

Table 8: Dynamic

Symbol	Parameter	Test Conditions	Min.	Тур.	Max.	Unit
g _{fs} (1)	Forward Transconductance	V _{DS} = 15 V _, I _D = 26 A		25		S
C _{iss} C _{oss} C _{rss}	Input Capacitance Output Capacitance Reverse Transfer Capacitance	$V_{DS} = 25V$, $f = 1$ MHz, $V_{GS} = 0$		4850 855 222		pF pF pF
Coss eq. (3)	Equivalent Output Capacitance	$V_{GS} = 0V, V_{DS} = 0V \text{ to } 200 \text{ V}$		720		pF
t _{d(on)} t _r t _{d(off)} t _f	Turn-on Delay Time Rise Time Turn-off Delay Time Fall Time	V_{DD} = 125V, I_{D} = 26 A R_{G} = 4.7 Ω V_{GS} = 10 V (see Figure 17)		40 75 115 55		ns ns ns ns
Q _g Q _{gs} Q _{gd}	Total Gate Charge Gate-Source Charge Gate-Drain Charge	V _{DD} = 200 V, I _D = 52 A, V _{GS} = 10V		160 32 87		nC nC nC

Table 9: Source Drain Diode

Symbol	Parameter	Test Conditions	Min.	Тур.	Max.	Unit
I _{SD} I _{SDM} (2)	Source-drain Current Source-drain Current (pulsed)				52 208	A A
V _{SD} (1)	Forward On Voltage	I _{SD} = 52 A, V _{GS} = 0			1.6	V
t _{rr} Q _{rr} I _{RRM}	Reverse Recovery Time Reverse Recovery Charge Reverse Recovery Current	$I_{SD} = 52 \text{ A, di/dt} = 100 \text{ A/}\mu\text{s}$ $V_{DD} = 100 \text{ V, T}_j = 25^{\circ}\text{C}$ (see Figure 18)		285 0.285 2		ns µC A
t _{rr} Q _{rr} I _{RRM}	Reverse Recovery Time Reverse Recovery Charge Reverse Recovery Current	$I_{SD} = 52 \text{ A, di/dt} = 100 \text{A/}\mu\text{s}$ $V_{DD} = 100 \text{ V, T}_j = 150 ^{\circ}\text{C}$ (see Figure 18)		336 0.37 2.2		ns µC A

Note: 1. Pulsed: Pulse duration = 300 μ s, duty cycle 1.5 %.

- 2. Pulse width limited by safe operating area.
- 3. Coss eq. is defined as a constant equivalent capacitance giving the same charging time as Coss when VDS increases from 0 to 80% VDSS

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Figure 3: Safe Operating Area

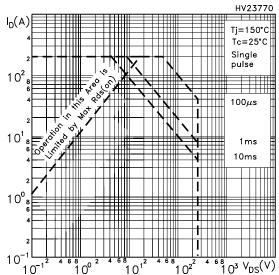


Figure 4: Output Characteristics

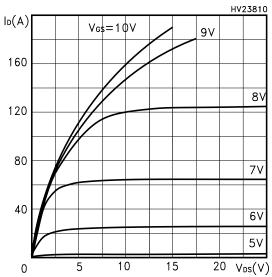


Figure 5: Transconductance

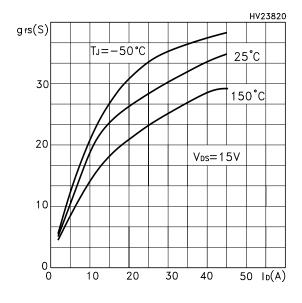


Figure 6: Thermal Impedance

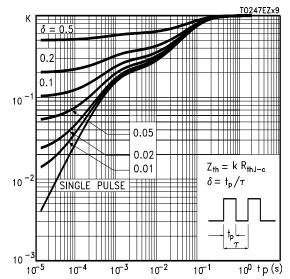


Figure 7: Transfer Characteristics

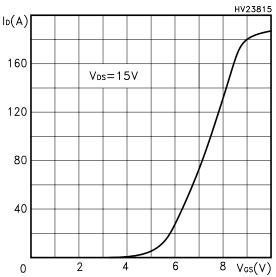


Figure 8: Static Drain-source On Resistance

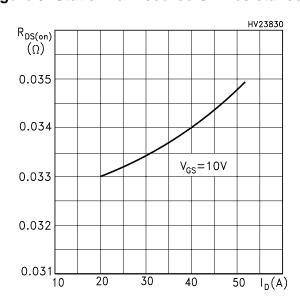


Figure 9: Gate Charge vs Gate-source Voltage

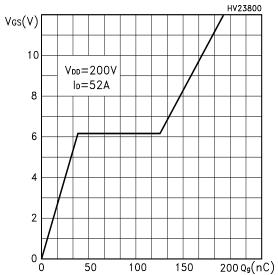


Figure 10: Normalized Gate Thereshold Voltage vs Temperature

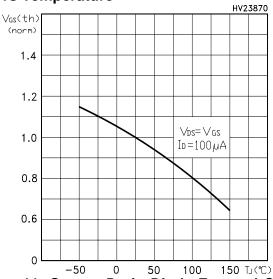


Figure 11: Source-Drain Diode Forward Characteristics

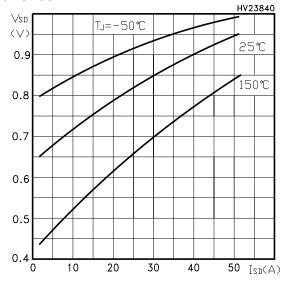


Figure 12: Capacitance Variations

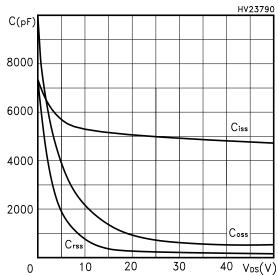


Figure 13: Normalized On Resistance vs Temperature

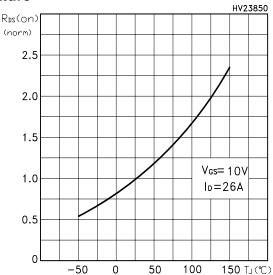


Figure 14: Normalized BVdss vs Temperature

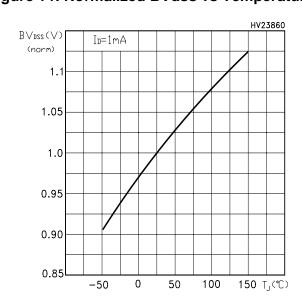




Figure 15: Avalanche Energy vs Starting Tj

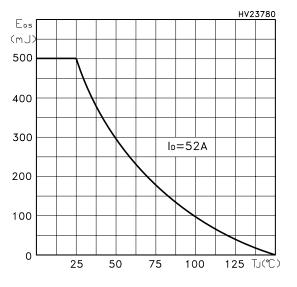




Figure 16: Unclamped Inductive Load Test Circuit

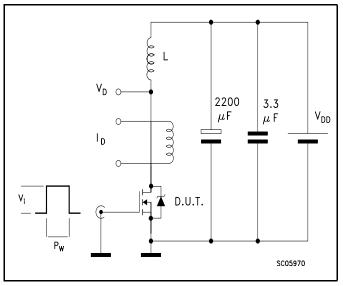


Figure 17: Switching Times Test Circuit For Resistive Load

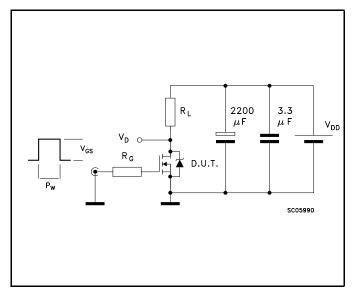


Figure 18: Test Circuit For Inductive Load Switching and Diode Recovery Times

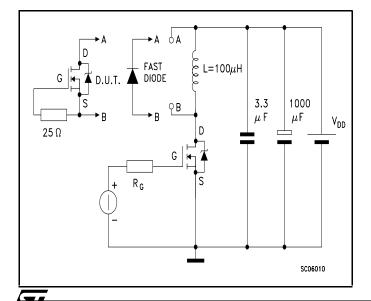


Figure 19: Unclamped Inductive Wafeform

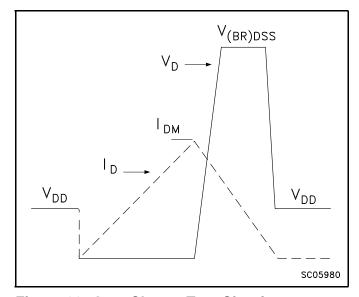
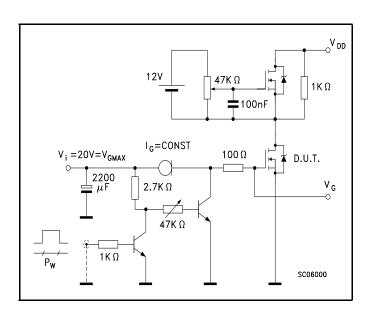


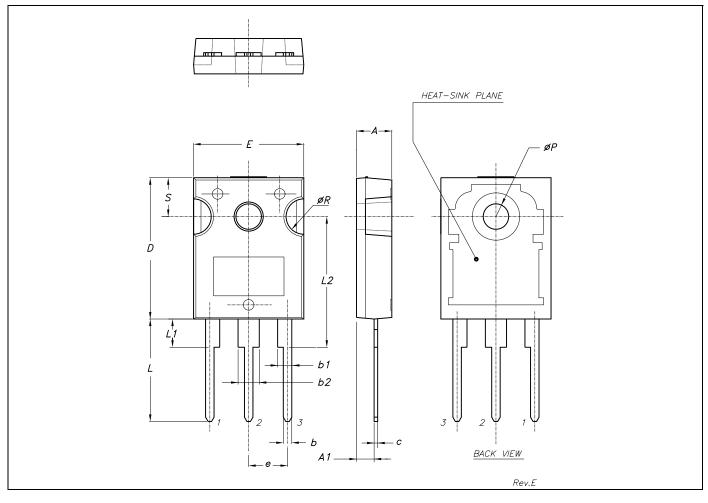
Figure 20: Gate Charge Test Circuit



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TO-247 MECHANICAL DATA

DIM.		mm.			inch	
DIWI.	MIN.	TYP	MAX.	MIN.	TYP.	MAX.
А	4.85		5.15	0.19		0.20
A1	2.20		2.60	0.086		0.102
b	1.0		1.40	0.039		0.055
b1	1 2.0 2.40 0.079			0.094		
b2	b2 3.0 3.		3.40	0.118		0.134
С	0.40		0.80	0.015		0.03
D	19.85		20.15	0.781		0.793
E	15.45		15.75	0.608		0.620
е		5.45			0.214	
L	14.20		14.80	0.560		0.582
L1	3.70		4.30	0.14		0.17
L2		18.50			0.728	
øΡ	3.55		3.65	0.140		0.143
øR	4.50		5.50	0.177		0.216
S		5.50			0.216	





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Table 10: Revision History

Date	Revision	Description of Changes
29-Oct-2004	1	First Relase
22-Nov-2004	2	Final datasheet



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